

**Search Notes**

Application/Control No.

10/530,267

Examiner

Raymond Phan

Applicant(s)/Patent under  
Reexamination

RADULESCU ET AL.

Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner
710	306-317, 104-110, 56-61	12/17/2007	RP
709	227-229	12/17/2007	RP
709	310-317	12/17/2007	RP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
710	316	12/21/2007	RP
709	227-228	12/21/2007	RP

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR